Application/Control No. 10/028,730 Applicant(s)/Patent Under Reexamination COLLINS ET AL. Examiner Han Lieh Liu Art Unit Page 1 of 1

Exc

Notice of References Cited

| | U.S. PATENT DOCUMENTS | | | | | | |
|---|-----------------------|--|-----------------|-----------------|----------------|--|--|
| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification | | |
| * | Α | US-6,318,101 | 11-2001 | Pham et al. | 62/225 | | |
| * | В | US-5,946,925 | 09-1999 | Williams et al. | 62/196.4 | | |
| 1 | С | US-5,820,352 🖊 | 10-1998 | Gunn et al. | 417/53 | | |
| * | D | US-5,772,403 / | 06-1998 | Allison et al. | 417/44.2 | | |
| * | E | US-5,209,076 | 05-1993 | Kauffman et al. | 62/126 | | |
| | F | US- | | | | | |
| | G | US- | | | | | |
| | Н | US- | | | | | |
| | 1 | US- | | | | | |
| | J | US- | | | | | |
| | К | US- | | | | | |
| | ٦ | US- | | | | | |
| | М | US- | | | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | 0 | | | | | |
| | Р | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | s | | | | | |
| | Т | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | w | |
| | x | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.